



UNA03R043M

Power MOSFET

40A, 30V N-CHANNEL POWER MOSFET

DESCRIPTION

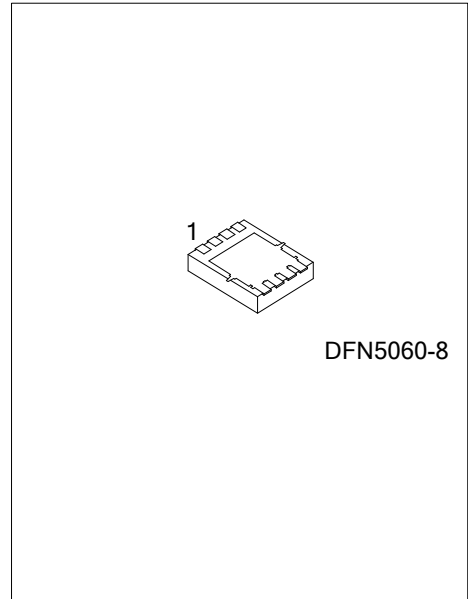
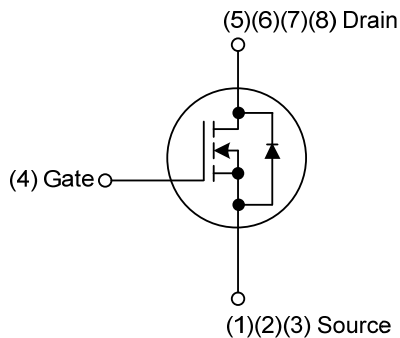
The UTC **UNA03R043M** is a N-channel enhancement mode power MOSFET using UTC's advanced technology to provide customers with ideal for low voltage inverter applications.

The UTC **UNA03R043M** is suitable for high efficiency synchronous rectification in SMPS, UPS, hard switched and high frequency circuits.

FEATURES

- * $R_{DS(ON)} < 4.3m\Omega @ V_{GS}=10V, I_D=20A$
- * $R_{DS(ON)} < 5.9m\Omega @ V_{GS}=4.5V, I_D=20A$
- * High speed switching
- * Low drive current

SYMBOL



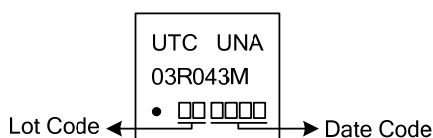
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment					Packing			
Lead Free	Halogen Free		1	2	3	4	5		6	7	8
UNA03R043ML-K08-5060-R	UNA03R043MG-K08-5060-R	DFN5060-8	G1	D1	D1	D1	G2	S2	S2	S2	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UNA03R043MG-K08-5060-R	(1)Packing Type	(1) R: Tape Reel
	(2)Package Type	(2) K08-5060: DFN5060-8
	(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING



■ ABSOLUTE MAXIMUM RATINGS (TC=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I_D	40	A
	Pulsed	I_{DM}	160	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	120	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	240	V/ns
Power Dissipation		P_D	15	W
Junction Temperature		T_J	+150	°C
Storage Temperature Range		T_{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive rating; pulse width limited by maximum junction temperature.

3. $L=0.15\text{mH}$, $I_{AS}=40\text{A}$, $V_{DD}=10\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

4. $I_{SD}\leq 40\text{A}$, $di/dt\leq 200\text{A}/\mu\text{s}$, $V_{DD}\leq BV_{DSS}$, starting $T_J=25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	65	°C/W
Junction-to-Case	θ_{JC}	8.33	°C/W

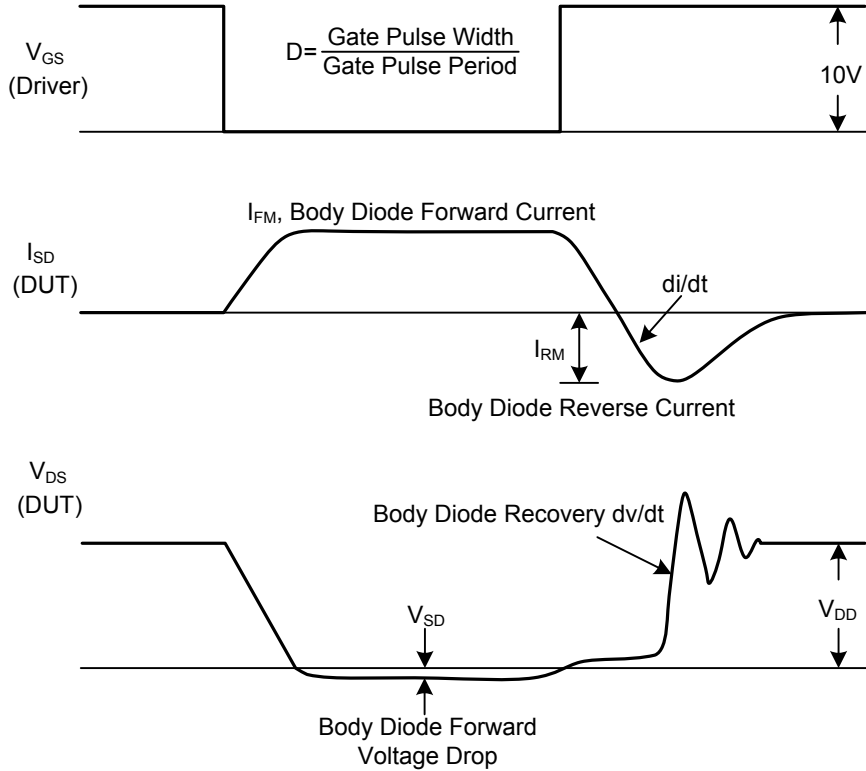
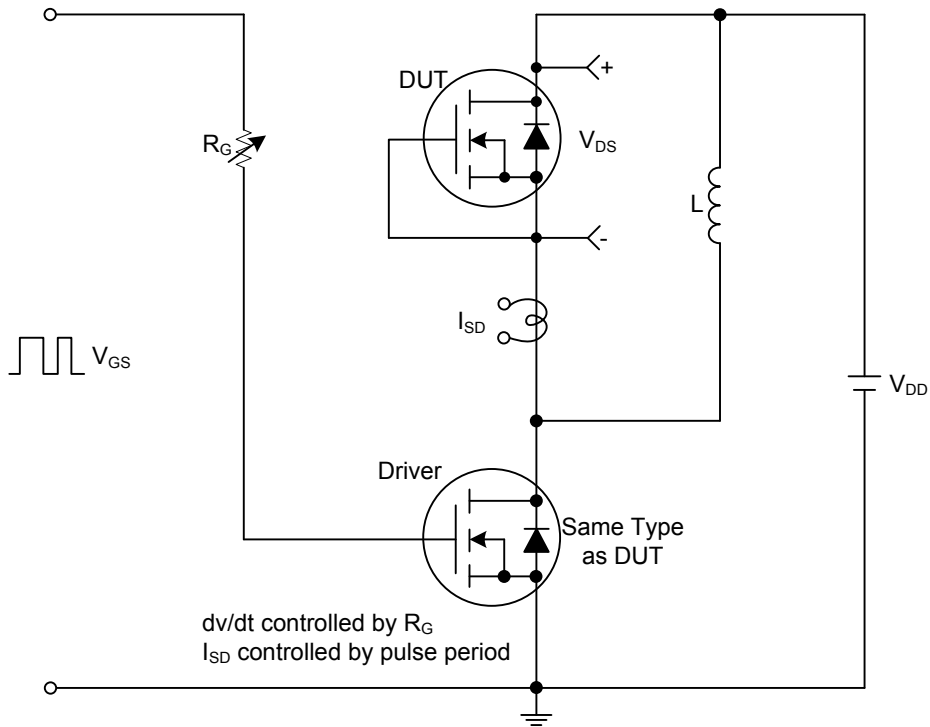
■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =10mA, V _{GS} =0V	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	Forward	I _{GSS}			0.1	μA
	Reverse					
		V _{GS} =-20V, V _{DS} =0V			-0.1	μA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =1mA	1.2		2.5	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =20A (Note 4)			4.3	mΩ
		V _{GS} =4.5V, I _D =20A (Note 4)			5.9	mΩ
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}	V _{GS} =0V, V _{DS} =10V, f=1.0MHz		3600		pF
Output Capacitance	C _{OSS}			650		pF
Reverse Transfer Capacitance	C _{RSS}			24		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q _G	V _{GS} =10V, V _{DD} =24V, I _D =40A		52.5		nC
Gate to Source Charge	Q _{GS}			22		nC
Gate to Drain Charge	Q _{GD}			5		nC
Turn-ON Delay Time	t _{D(ON)}	V _{GS} =10V, V _{DD} ≈15V, I _D =20A, R _G =4.7Ω, R _L =0.5Ω		24.4		ns
Rise Time	t _R			7.5		ns
Turn-OFF Delay Time	t _{D(OFF)}			76		ns
Fall-Time	t _F			29		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I _S				40	A
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				160	A
Source to Drain Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _F =40A		0.83	1.08	V
Reverse Recovery Time	t _{rr}	I _F =40A, V _{GS} =0, di _F /dt=100A/μs		304		ns
Body Diode Reverse Recovery Charge	Q _{rr}				6.18	

Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.

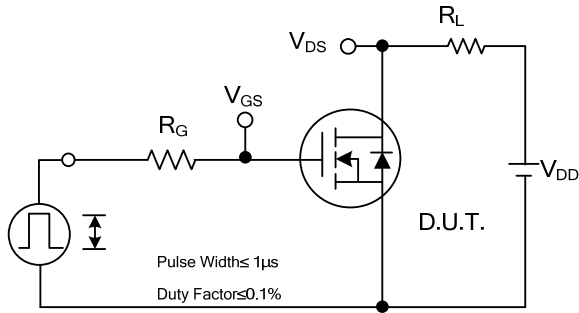
2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

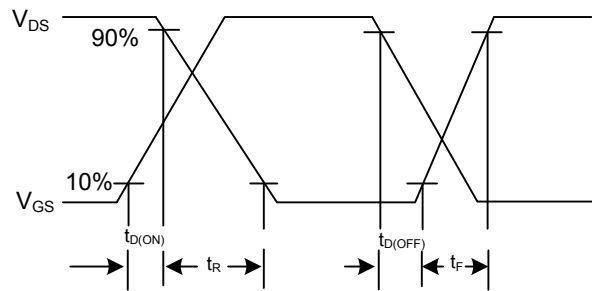


Peak Diode Recovery dv/dt Test Circuit and Waveforms

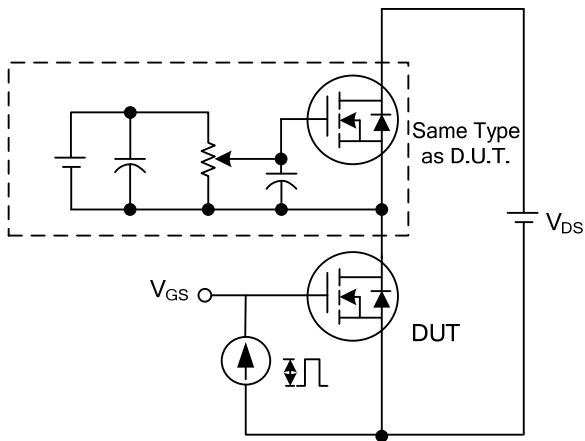
■ TEST CIRCUITS AND WAVEFORMS



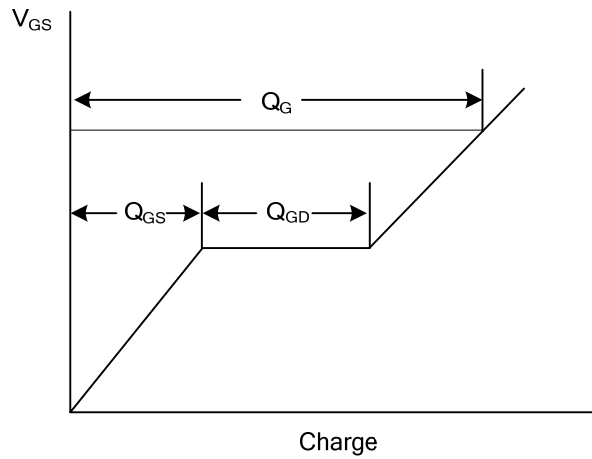
Switching Test Circuit



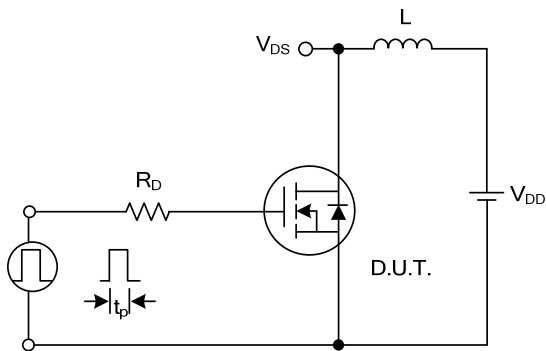
Switching Waveforms



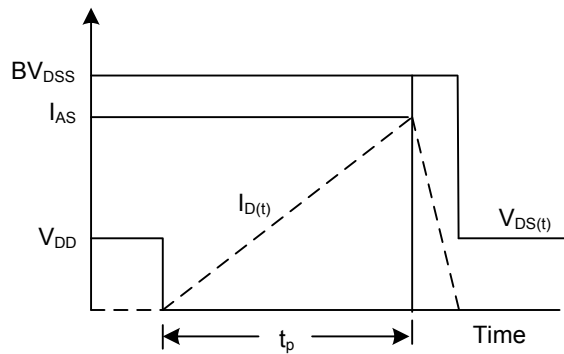
Gate Charge Test Circuit



Gate Charge Waveform

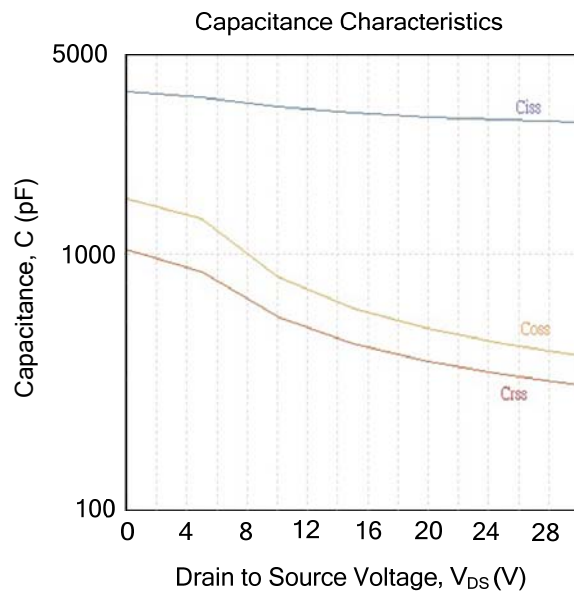
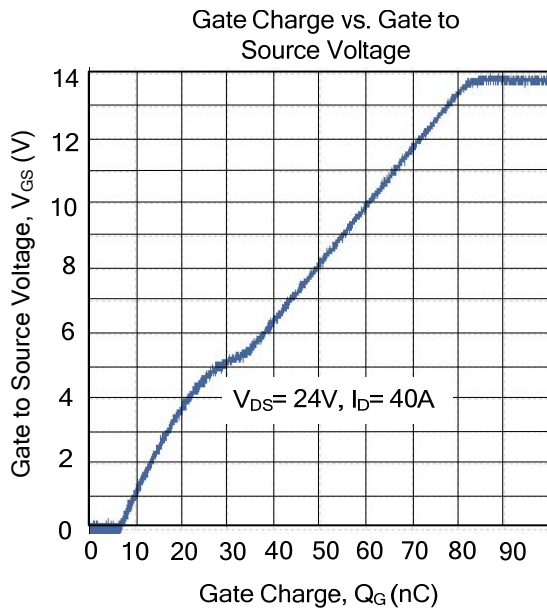


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

TYPICAL CHARACTERISTICS



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